

SUPER-SEMI



SUPER-MOSFET

Super Junction Metal Oxide Semiconductor Field Effect Transistor

650V Super Junction Power MOSFET Gen-II SS*65R650S2

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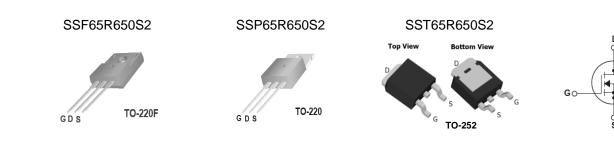
SSF65R650S2/SSP65R650S2/SST65R650S2 650V N-Channel Super-Junction MOSFET Gen-II

Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

Features

- Multi-Epi process SJ-FET
- 700V @TJ = 150 °C • Typ. RDS(on) = 0.55Ω
- Ultra Low Gate Charge (typ. Qg = 13.6nC)
- 100% avalanche tested



Absolute Maximum Ratings

Symbol	Parameter	SSP_T65R650S2	SSF65R650S2	Unit
V _{DSS}	Drain-Source Voltage	650		V
ID	Drain Current -Continuous (TC = 25°C) -Continuous (TC = 100°C)	7.8* 4.9*		А
I _{DM}	Drain Current - Pulsed (Note 1)	31.2	31.2	
V _{GSS}	Gate-Source voltage	±30	±30	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	106)6	
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj max)	2.7	2.7	
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15		V/ns
dVds/dt	Drain Source voltage slope (Vds=480V)	50	50	
PD	Power Dissipation (TC = 25°C)	80	30	w
Tj, T _{stg}	Operating and Storage Temperature Range	-55 to +150		°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/16" from Case for 10 Seconds	260		°C

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75.

Thermal Characteristics

Symbol	Parameter	SSP_T65R650S2	SSF65R650S2	Unit
$R_{\theta JC}$ Thermal Resistance, Junction-to-Case		1.55	4.2	°C/W
R _{0CS} Thermal Resistance, Case-to-Sink Typ.		0.5	-	°C/W
R _{0JA}	Thermal Resistance, Junction-to-Ambient	62	80	°C/W

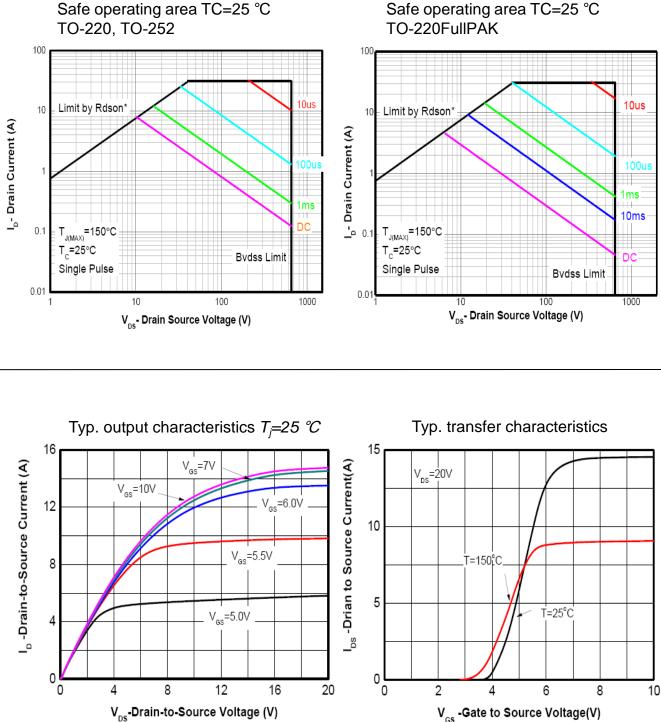


Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Off Charact	eristics					
		VGS = 0V, ID = 250µA, TJ = 25°C	650	-	-	V
BVDSS	Drain-Source Breakdown Voltage	Vgs = 0V, Id = 250µA, TJ = 150°C	-	700	-	V
ΔBVdss/ΔTj	Breakdown Voltage Temperature Coefficient	$ID = 250\mu A$, Referenced to $25^{\circ}C$	-	0.6	-	V/°C
IDSS	Zero Gate Voltage Drain Current	VDS = 650V, VGS = 0V -TC = 125°C	-	-	1 100	μΑ μΑ
IGSSF	Gate-Body Leakage Current, Forward	Vgs = 30V, Vds = 0V	-	-	100	nA
IGSSR	Gate-Body Leakage Current, Reverse	Vgs = -30V, Vds = 0V	-	-	-100	nA
On Charact	eristics					
VGS(th)	Gate Threshold Voltage	Vds = Vgs, Id = 250µA	2.0	3.0	4.0	V
BDC (an)	Static Drain-Source On-Resistance	Vgs = 10V, ID = 3.5A (TO-220, TO-220F)	-	0.55	0.65	Ω
RDS(on)		VGS = 10V, ID = 3.5A (TO-252)	-	0.56	0.67	Ω
Dynamic Ch	naracteristics					
Ciss	Input Capacitance		-	480	-	pF
Coss	Output Capacitance	── VDS = 100V, VGS = 0V, ── f = 1.0MHz	-	22	-	pF
Crss	Reverse Transfer Capacitance		-	1.1	-	pF
Qg	Total Gate Charge		-	13.6	-	nC
Qgs	Gate-Source Charge	-VDS = 400V, ID = 7.8A,	-	3.2	-	nC
Qgd	Gate-Drain Charge	VGS = 10V (Note 4)	-	5.6	-	nC
Rg	Gate resistance	f=1 MHz, open drain	-	9.6	-	Ω
Switching C	Characteristics					
td(on)	Turn-On Delay Time		-	11	-	ns
tr	Turn-On Rise Time	VDS = 400V, ID = 3.9A	-	21	-	ns
td(off)	Turn-Off Delay Time	$R_{G} = 10\Omega$, VGS = 10V	-	40	-	ns
tf	Turn-Off Fall Time	(Note 4)	-	31	-	ns
Drain-Sourc	ce Diode Characteristics and Maximum	Ratings		1		-
ls	Maximum Continuous Drain-Source Diod	•	-	-	7.8	A
ISM	Maximum Pulsed Drain-Source Diode Forward Current		-	-	31.2	A
VSD	Drain-Source Diode Forward Voltage	VGS = 0V, $IS = 7.8A$	-	0.9	1.4	V
trr	Reverse Recovery Time		-	205	-	ns
Qrr	Reverse Recovery Charge	- VGS = 0V, VDS = 400V,	-	1.4	-	μC
Irrm	Peak Reverse Recovery Current	— Is = 3.9A, dI⊧/dt =100A/µs	-	12	-	A

NOTES:

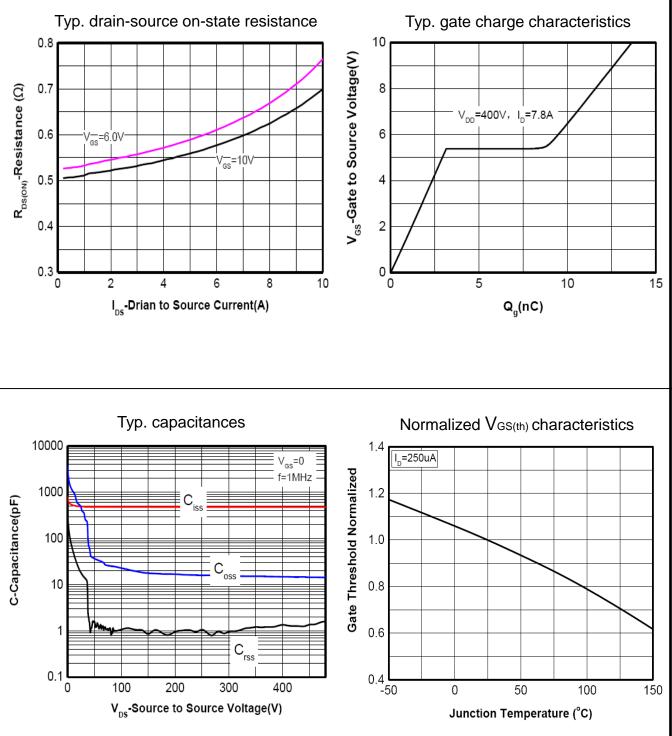
1. Repetitive Rating: Pulse width limited by maximum junction temperature 2. ID=I_{AS}, VDD=50V, Starting TJ=25 °C 3. I_{SD}≤ID, di/dt ≤ 200A/us, V_{DD} ≤ BV_{DSS}, Starting TJ = 25 °C 4. Essentially Independent of Operating Temperature Typical Characteristics



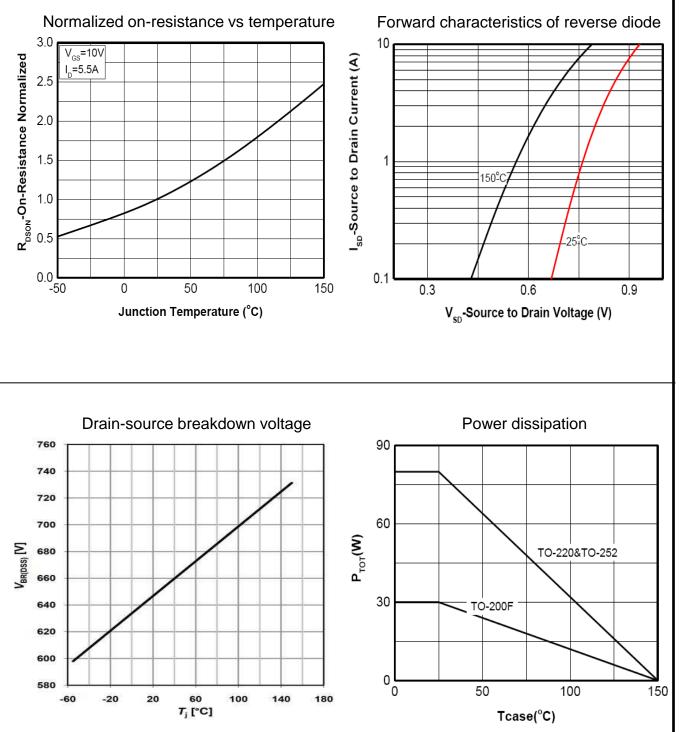


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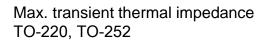


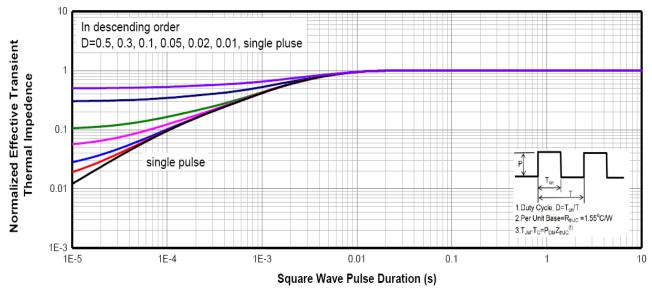




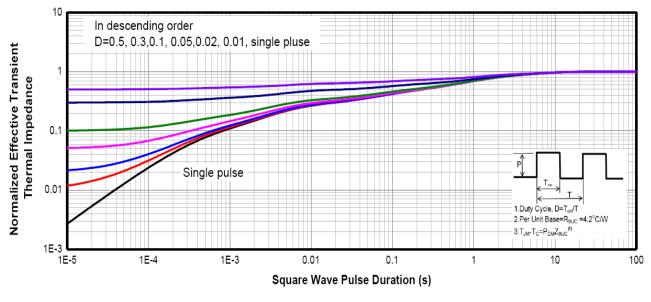




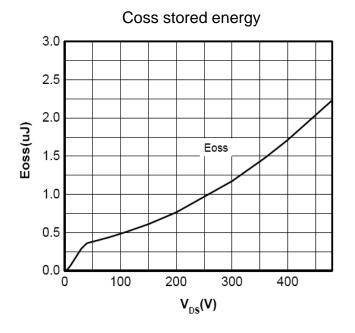




Max. transient thermal impedance TO-220FullPAK

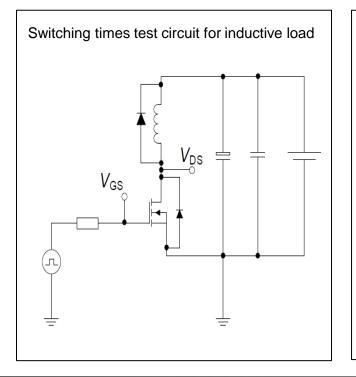


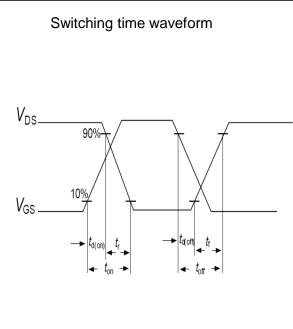




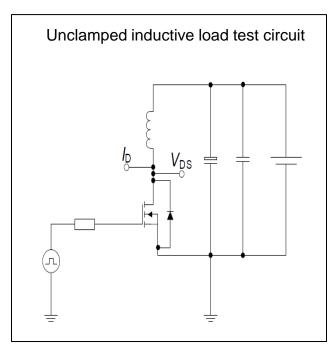


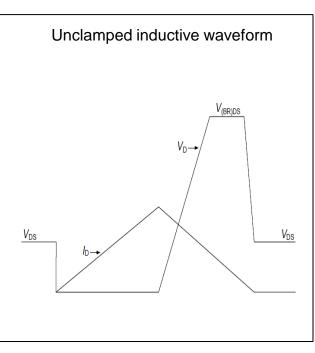
Switching times test circuit and waveform for inductive load





Unclamped inductive load test circuit and waveform

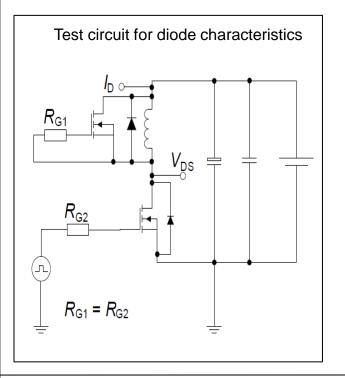


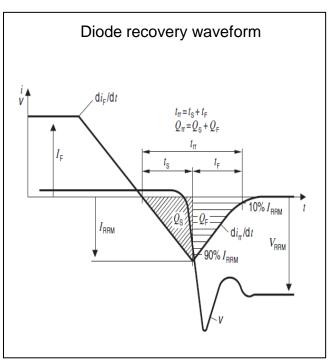


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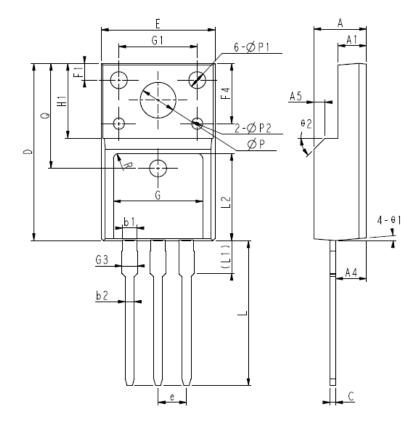


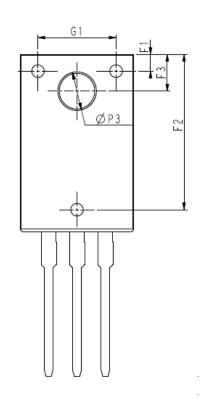
Test circuit and waveform for diode characteristics





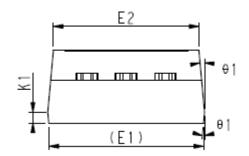




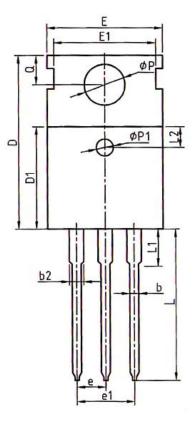


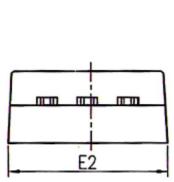
COMMON DIMENSIONS

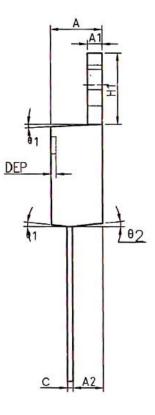
	ММ			
SYMBOL	MIN	NOM	MAX	
E	10.00	10.16	10.32	
E1	9.94	10.04	10.14	
E2	9.36	9.46	9.56	
A	4.50	4.70	4.90	
A1	2.34	2.54	2.74	
A4	2.66	2.76	2.86	
A5		1.00REF		
с	0.45	0.50	0.60	
D	15.67	15.87	16.07	
Q		9.40REF		
H1	6. 70REF			
е		2.54BSC		
ΦP	3. 18REF			
L	12.78	12.98	13.18	
L1	2.83	2.93	3.03	
L2	7.70	7.80	7.90	
ΦΡ1	1.40	1.50	1.60	
Φ P 2	0.95	1.00	1.05	
Φ P 3		3.45REF		
0 <u>1</u>	3°	5°	7°	
θ 2	-	45°	-	
F1	1.00	1.50	2.00	
F2	13.80	13.90	14.00	
F3	3.20	3.30	3.40	
F4	5.30	5.40	5.50	
G	7.80	8.00	8.20	
G1	6.90	7.00	7.10	
G3	1.25	1.35	1.45	
b1	1.23	1.28	1.38	
b2	0.75	0.80	0.90	
K1	0.65	0.70	0.75	
R		0.50REF		









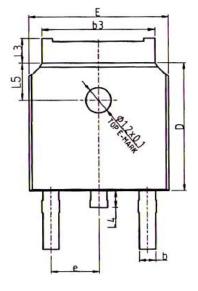


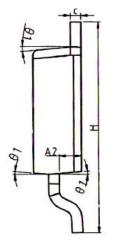
COMMON DIMENIONS

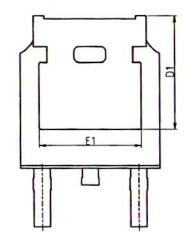
SYMBOL	P	IM	3.
STMBUL	MIN	NDM	MAX
A	4.40	4.57	4.70
A1	1.27	1.30	1.37
A2	2.35	2.40	2.50
b	0.77	0.80	0.90
b2	1.17	1.27	1.36
c	0.48	0.50	0.56
D	15.40	15.60	15.80
D1	9.00	9.10	9.20
DEP	0.05	0.10	0.20
Ε	9.80	10.00	10.20
E1	-	8.70	-
E2	9.80	10.00	10.20
¢P1	1.40	1.50	1.60
e		2.54BS0	;
e1		5.08BS	C
H1	6.40	6.50	6.60
L	12.75	13.50	13.65
L1	-	3.10	3.30
12		2.50REF	
ØP	3.50	3.60	3.63
Q	2.73	2.80	2.87
θ1	5	T	9'
θ2	ľ	3	5
0 3	1'	3	5'

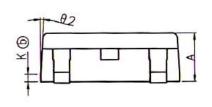


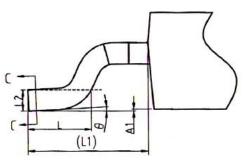
Package Outline TO-252

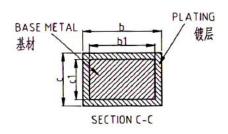












COMMON DIMENSIONS					
SYMBOL	MM				
SYMBOL	MIN	NOM	MAX		
Α	2.20	2.30	2.38		
A1	0.00	-	0.10		
A2	0.97	1.07	1.17		
b	0.72	0.78	0.85		
b1	0.71	0.76	0.81		
b3	5.23	5.33	5.46		
с	0.47	0.53	0.58		
c1	0.46	0.51	0.56		
D	6.00	6.10	6.20		
D1		5.30REF			
E	6.50	6.60	6.70		
E1	4.70	4.83	4.92		
е		2.286BSC			
H	9.90	10.10	10.30		
L	1.40	1.50	1.70		
L1		2.90REF			
L2		0.51BSC			
L3	0.90	-	1.25		
L4	0.60	0.80	1.00		
L5	1.70 1.80 1.9				
θ	0°	-	8°		
θ1	5°	7°	9°		
θ2	5°	7°	9°		
K	K 0.40REF				



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